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# UTILITY PATENT APPLICATION TRANSMITTAL

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Attorney Docket No. R11.12-0701

First Inventor or Application Identifier Eric R. Lovegren et al.

Title IMPROVED THRESHOLD SETTING FOR A RADAR  
LEVEL TRANSMITTER

Express Mail Label No. EL636048837US

## APPLICATION ELEMENTS

See MPEP chapter 600 concerning utility patent application contents

Address To:

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1. ☒ \*Fee Transmittal Form e.g., PTO/SB17  
(Submit an original and a duplicate for fee processing)
2. ☒ Specification [Total Sheets 29]  
(preferred arrangement set forth below)
  - Descriptive title of the Invention
  - Cross References to Related Applications
  - Statement Regarding Fed sponsored R & D
  - Reference to Microfiche Appendix
  - Background of the Invention
  - Brief Summary of the Invention
  - Brief Description of the Drawings (if filed)
  - Detailed Description
  - Claim(s)
  - Abstract of the Disclosure
3. ☒ Drawing(s) (35 U.S.C. § 113) [Total Sheets 5]
4. Oath or Declaration [Total Sheets 3]
  - a. ☒ Newly executed (original or copy)
  - b. ☐ Copy from a prior application (37 C.F.R. § 1.63(d))  
(for continuation/divisional with Box 16 completed)
  - i. ☐ DELETION OF INVENTOR(S)  
Signed statement attached deleting  
inventor(s) named in the prior application,  
see 37 C.F.R. §§1.63(d)(2) and 1.33(b).

\* NOTE FOR ITEMS 1 & 13: IN ORDER TO BE ENTITLED TO PAY SMALL ENTITY  
FEES, A SMALL ENTITY STATEMENT IS REQUIRED (37 C.F.R. § 1.27), EXCEPT  
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5. ☐ Microfiche Computer Program (Appendix)
6. ☐ Nucleotide and/or Amino Acid Sequence Submission  
(If applicable, all necessary)
  - a. ☐ Computer Readable Copy
  - b. ☐ Paper Copy (Identical to computer copy)
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## ACCOMPANYING APPLICATION PARTS

7. ☒ Assignment Papers (cover sheet & document(s))
8. ☐ 37 C.F.R. § 3.73(b) Statement (when there is an assignee) ☒ Power of Attorney
9. ☐ English Translation Document
10. ☐ Information Disclosure Statement (IDS/PTO - PTO) ☐ Copies of IDS
11. ☐ Preliminary Amendment
12. ☒ Return Receipt Postcard (MPEP 503)
13. ☐ \*Small Entity ☐ Statement filed in prior application.  
Statement(s) Status still proper and desired  
(PTO/SB/09-12)
14. ☐ Certified Copy of Priority Document(s)  
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16. If a CONTINUING APPLICATION, check appropriate box, and supply the requisite information below and in a preliminary amendment:

☐ Continuation ☐ Divisional ☐ Continuation -in part (CIP)

of prior application No: \_\_\_\_\_

Prior application information:

Examiner \_\_\_\_\_

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## 17. CORRESPONDENCE

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# FEE CALCULATION SHEET

Attorney Docket No.

R11.12-0701

Sir:

Express Mail No. EL636048837US  
Date of Deposit: September 22, 2000

The fees due for filing in the patent application of:

Inventor(s) : Eric R. Lovegren et al.

Title : IMPROVED THRESHOLD SETTING FOR A RADAR LEVEL TRANSMITTER

Are calculated as follows:

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INDEP CLAIMS	3 - 3 =	* 0	X 39 =	\$		X 78 =	\$0
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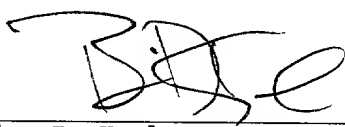
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X The Director is authorized to charge payment of any patent application processing or filing fees under 37 CFR §§ 1.16 and 1.17 or credit any overpayment to Deposit Account No. 23-1123. A duplicate copy of this sheet is enclosed.

Respectfully submitted,

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PATENT APPLICATION OF

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ENTITLED

IMPROVED THRESHOLD SETTING FOR A RADAR  
LEVEL TRANSMITTER

Docket No. R11.12-0701

## IMPROVED THRESHOLD SETTING FOR A RADAR LEVEL TRANSMITTER

### BACKGROUND OF THE INVENTION

The present invention relates to radar  
5 level transmitters used in the process control  
industry to measure levels of materials in storage  
vessels, such as tanks. More particularly, the  
present invention relates to a threshold level  
calculation for establishing threshold levels that  
10 can be used by a radar level transmitter to identify  
material interfaces which are used to calculate  
material levels.

Radar level transmitters are used in the  
process control industry to measure levels of  
15 materials contained in a tank or vessel by  
transmitting a microwave pulse into the tank using a  
radar antenna, receiving a signal relating to  
reflections of the transmitted microwave pulse, and  
detecting material interfaces formed by the materials  
20 using the signal. Radar level transmitters are also  
generally adapted to transmit level information  
relating to the material interfaces to a distant  
control system.

The materials in the tank could be in a  
25 gas, solid, or liquid state. The microwave pulse  
reflects off the contents of the tank and a return  
profile of the tank is generated as a signal or  
waveform. The waveform represents the amplitude of  
the reflections of the microwave pulses that are

received by the radar level transmitter as a function of time. Peaks in the waveform represent received wave pulses corresponding to portions of the microwave pulse that were reflected off impedance discontinuities within the tank. These discontinuities can include various material interfaces such as an antenna-gas interface, a gas-liquid interface, a gas-solid interface, a liquid-liquid interface, such as a layer of oil on water, a liquid-solid interface, a solid-solid interface, and other types of material interfaces. It is desirable to measure the location of these interfaces in order to determine the quantities of the various types of materials in the tank.

The location or levels of these material interfaces can be established using common Time Domain Reflectometry (TDR) principles once the corresponding time locations of the received wave pulses or peaks in the waveform are established relative to a reference time location. Detection of the time location of the received wave pulses generally includes analyzing the waveform for peaks, which exceed a predetermined threshold value. If the tank includes more than one material, multiple threshold values, each relating to a specific material interface, can be used to detect the levels of the various materials.

There is an ongoing need for improved radar level transmitters. Currently, the threshold values

are empirically set by an operator of the radar level transmitter. In addition to being time-consuming and requiring a trained operator, this method can lead to inaccurate threshold value settings, which can result  
5 in detection errors and erroneous level measurement. Additionally, the amplitudes of the received wave pulses generally have a dependence on several parameters relating to, for example, the properties of the materials contained in the tank, the tank  
10 size, the properties of the radar antenna, and temperature. Thus, the threshold values may need to be adjusted each time one of the parameters affecting the amplitudes of the received wave pulses changes, to prevent erroneous measurements. Automation of the  
15 setting of the threshold values could save money by increasing the accuracy of the threshold values and reducing the need for trained personnel.

SUMMARY OF THE INVENTION \_

A method and apparatus for setting threshold values for use by a radar level transmitter to detect reflected wave pulses corresponding to portions of a transmitted microwave pulse which reflect from interfaces contained in a container. The present invention estimates these threshold values based upon various parameters, some of which relate to properties of the materials forming the interfaces while others relate to properties of the antenna and user-defined parameters.

BRIEF DESCRIPTION OF THE DRAWINGS

FIG. 1 is a simplified diagram showing radar level transmitter, in accordance with various embodiments of the invention, attached to tanks in a process plant.

FIG. 2 is a simplified block diagram of a radar level transmitter, in accordance with one embodiment of the invention.

FIG. 3 is plot of a waveform generated by a radar level transmitter, in accordance with another embodiment of the invention.

FIG. 4 is a simplified block diagram of a microprocessor system of a radar level transmitter, in accordance with an embodiment of the invention.

FIG. 5 is flow chart illustrating methods which can be implemented by a radar level transmitter

in accordance with various embodiments of the invention.

DETAILED DESCRIPTION OF THE PREFERRED EMBODIMENT

The present invention relates to radar  
5 level transmitters that can be used to determine the  
level of materials, such as liquids and solids,  
contained in a tank, pipe, vessel or other type of  
container. The present invention automatically  
determines threshold values which are used by radar  
10 level transmitters to locate the levels of the  
materials.

FIG. 1 shows an example of an environment  
in which radar level transmitters 10 generally  
operate. Radar level transmitters 10 can be mounted  
15 on tank 12 above, for example, first, second, and  
third materials 13, 14, and 16, respectively. A first  
material interface 18 is located at the junction of  
first material 13 and second material 14. A second  
material interface 20 is located at the junction  
20 between second material 14 and third material 16.  
Each radar level transmitter 10 attaches to a radar  
antenna 22 which generally transmits a microwave  
pulse into materials 13, 14, and 16.

The transmitted microwave pulse can consist  
25 of a wide range of frequencies. Preferred frequencies  
include 250 MHz to in excess of 20 GHz. In one  
embodiment, the frequency of the microwave pulse is  
about 2 GHz having a pulse duration range from  
approximately 200 picoseconds to approximately 2



radar level transmitters 10 over 2-wire control loops 26. Control loop 26 can be an analog loop, using as a standard 4-20 mA analog signal, or a digital loop, which produces a digital signal in accordance with a digital communication protocol such as FOUNDATION™ Fieldbus or Profibus, or a combination loop, where a digital signal is superimposed upon an analog signal, such as with the Highway Addressable Remote Transducer (HART®). Additionally, radar level transmitter 10 can be a low power transmitter, which is completely powered by energy received over control loop 26.

FIG. 2 is a simplified block diagram of radar level transmitter 10 coupled to control room 24 over control loop 26. Electronic circuitry contained in housing 28 of transmitter 10 includes microprocessor system 30, microwave transceiver 32, communications module 34, and power module 36. Radar level transmitter 10 also includes radar antenna 22 depicted as waveguide 22a extending into second and third materials 14 and 16 contained in tank 12.

Microwave transceiver 32 is operatively coupled to antenna 22 and is controlled by microprocessor system 30. Microwave transceiver 32 is adapted to transmit a microwave pulse into tank 12 through antenna 22 and to receive the resulting reflected wave pulses. Microwave transceiver 32 is further adapted to communicate the reflected wave pulses to microprocessor system 30 in the form of an electrical signal having an amplitude that can be

plotted with respect to time to form a waveform, such as waveform 38 illustrated in FIG. 3. Transceiver 32 can be a low power microwave transceiver operable within the power constraints of a low power radar level transmitter 10. For example, transceiver 32 can be a micropower impulse radar (MIR) transceiver of the type discussed in detail in either of two patents issued to Thomas E. McEwan, U.S. Patent No. 5,609,059 entitled ELECTRONIC MULTI-PURPOSE MATERIAL LEVEL SENSOR and U.S. Patent No. 5,610,611 entitled HIGH ACCURACY ELECTRONIC MATERIAL LEVEL SENSOR.

Microprocessor system 30 is coupled to microwave transceiver 32 and is adapted to calculate interface locations, or levels of materials based upon the time locations of the reflected wave pulses or their time of flight using known TDR principles. Microprocessor system 30 is further configured to produce an output signal that is indicative of the position of first material interface 18 and/or second material interface 20 referred to as a level output signal. The level output signal can be communicated to control room 24 through input/output port 39 using communications module 34. Additionally, microprocessor system 30 can receive information provided at input/output port 39 through communications module 34.

Communications module 34 is coupled to microprocessor system 30 and input/output port 39. In one embodiment, input/output port includes terminals

5 Additionally, communications module 34 can receive information through input/output port 39, such as calibration information and various parameters that can be processed by microprocessor system 30 to perform calculations relating to the level of  
10 materials contained in tank 12. Such information can be transmitted and received by communications module 34 over, for example, control loop 26, in accordance with a digital communication protocol using appropriate circuitry such as a known Universal  
15 Asynchronous Receiver Transmitter (UART) (not shown). Alternatively, information can be transmitted and received as an analog signal where a current signal in control loop 26 varies between, for example, 4 and 20 mA. Communications module 34 may use a digital-to-  
20 analog converter or other appropriate device to translate the digital signal from microprocessor system 30 to an analog signal that can be transmitted over control loop 26. Likewise, communications module 34 can use an analog-to-digital (A/D) converter to  
25 convert an analog signal received from control loop 26 to a digital signal that can be utilized by microprocessor system 30, if necessary. In this manner, transmitter 10 can communicate the levels of first material interface 18 and/or second material

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the mismatch of the characteristic impedances of the materials.

As mentioned above, discontinuities can exist at first material interface 18, second material  
5 interface 20, and fiducial interface 40, which are shown in FIG. 2. A discontinuity exists at first material interface 18 due to the mismatched impedances between first material 13 and second material 14. Likewise, a discontinuity exists at second material  
10 interface 20 due to the mismatched impedances between second and third materials 14 and 16. Consequently, first and second reflected wave pulses 44, 46 are produced at first and second material interfaces 18, 20, respectively, in response to a transmitted  
15 microwave pulse. FIG. 3 shows waveform 38, in the form of a plot of reflected energy received by microwave transceiver 32, which depicts examples of first and second reflected wave pulses 44 and 46.

Fiducial interface 40 is a reference  
20 impedance mismatch or discontinuity that produces a reflected wave pulse in the form of a fiducial pulse 48, shown in FIG. 3, in response to the transmitted microwave pulse. Fiducial interface 40 is a known impedance mismatch within the path of the transmitted  
25 microwave pulse that typically does not change over time. Fiducial interface 40 is typically a component/air interface, but can be any boundary between two substances that have different dielectric constants. Fiducial interface 40 could be located, for

example, between first material 13, disposed above first material interface 18, and launch plate 45 (FIG. 2), antenna 22, a series capacitor (not shown), or any other suitable component. Fiducial pulse 48 can be used  
5 as a reference, from which the times of flight, or the time locations relative to fiducial pulse 48, of first and second reflected wave pulses 44 and 46 can be determined. The levels of first and second material interfaces 18 and 20 can then be calculated using the  
10 times of flight or relative time locations, using known TDR principles.

The general method used by microprocessor system 30 to detect fiducial pulse 48, first reflected wave pulse 44, and second reflected wave pulse 46,  
15 involves establishing threshold values which correspond to each of the reflected wave pulses of waveform 38. The time location of a particular reflected wave pulse can be ascertained by determining where waveform 38 crosses a threshold value that is set to detect the  
20 particular reflected wave pulse. The time location of a detected reflected wave pulse could be taken at many locations. These locations include: the leading edge of the reflected wave pulse; the trailing edge of the reflected wave pulse, midway between the points which  
25 cross the threshold value, the peak value of the reflected wave pulse that lies above the threshold value or, any other suitable location along the detected reflected wave pulse. In the illustration of FIG. 3, fiducial threshold value TF is defined to

5           The threshold values needed to detected a  
desired reflected wave pulse can change as properties  
of transmitter 10 and properties of the contents of  
tank 12 change. For example, if radar antenna 22 is  
changed from radar horn 22B to wave-guide 22A,  
10 threshold values TF, T1 and T2 may need adjustment to  
ensure that they properly detect the associated  
reflected wave pulse 48, 44, and 46, respectively.  
Additionally, changes in temperature and pressure can  
also have an effect on the properties of antenna 22 and  
15 the materials contained within tank 12, thus requiring  
modifications to threshold values TF, T1 and T2.

Use of empirical methods to set the threshold values TF, T1 and T2 can be time-consuming, especially when they require periodic adjustment due to changing properties of transmitter 10, environmental parameters, and/or the contents of tank 12. The present invention improves on the prior art by providing a method for setting threshold values TF, T1 and T2 quickly and accurately. In addition, the method used by the present invention to set threshold values TF, T1 and T2 allows for easy adjustment of threshold values TF, T1 and T2 when the properties of transmitter 10, environmental parameters, or the materials contained within tank 12 change.

The threshold calculations of the present invention are generally performed by software instructions. Although the following describes the software instructions as being stored within  
5 microprocessor system 30, it should be understood that the software instructions could be stored and executed externally to transmitter 10, such as in control room 24, where threshold values TF, T1 and T2 are communicated to microprocessor system 30 through  
10 input/output port 39 and communications module 34.

Referring now to FIG. 4, one embodiment of microprocessor system 30 includes microprocessor 50, memory 52, input/output (I/O) port 53, clock 54, and analog-to-digital (A/D) converter 55. Clock 54  
15 communicates a clock signal to microprocessor 50 and is used to control the operations of microprocessor 50. Microprocessor 50 communicates with memory 52 and is adapted to store and retrieve data from memory 52 and retrieve and execute instructions stored in memory 52.  
20 I/O port 53 allows microprocessor system 30 to communicate with microwave transceiver 32 and communications module 34, shown in FIG. 2. A/D converter 55 can be used by microprocessor system 30 to convert analog signals received from I/O port 53 to  
25 digital form for microprocessor 50. Typically, all components in A/D converter 55 are controlled by a clock signal which can be derived from clock 54.

Memory 52 includes threshold calculation module 56 and level calculation module 58, which each

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contain instructions that can be executed by microprocessor 50. Threshold calculation module 56 is configured to provide level calculation module 58 with threshold values that are used by level calculation  
5 module 58 to detect reflected wave pulses in waveform 38 received from microwave transceiver 32. In one embodiment, threshold calculation module 56 provides fiducial threshold value TF and first threshold value T1 for standard level detection by level calculation  
10 module 58. In another embodiment, threshold calculation module further provides second threshold value T2 and additional threshold values as are needed by level calculation module 58 to perform interface detection below first material interface 18.

15 FIG. 5 shows a flow chart of a general method that can be used to provide threshold calculations to establish fiducial threshold value TF, first threshold value T1, and second threshold value T2. At step 60, a correction factor is set in  
20 accordance with the properties of radar antenna 22 (FIG. 1) used by radar level transmitter 10. These properties can include, for example, the dimensions of the conductors used in a co-axial seal probe or a two-wire probe. At step 62, a first dielectric parameter is  
25 set to a value that corresponds to the dielectric of first material 13 at fiducial interface 40. It should be understood that the medium at fiducial interface is typically gas, but could be a liquid or solid as well. The dielectric of the first material 13 will generally

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have a dependence upon the vapor content of the gas. A reference amplitude is set to a value that relates to the amplitude of the transmitted microwave pulse, at step 64. At step 66, a second dielectric parameter is set to a value that corresponds to the dielectric of second material 14. At step 68, an estimated first pulse amplitude is calculated as a function of the reference amplitude, the correction factor, the first dielectric parameter, and the second dielectric parameter. The estimated first pulse amplitude relates to the first reflected wave pulse 44 corresponding to a portion of the transmitted microwave pulse that is reflected at first material interface 18. These calculations are known in the industry and can be found in textbooks relating to electromagnetics, such as the Fundamentals Of Applied Electromagnetics 1999 Edition, by Fawwaz T. Ulaby, published by Prentice-Hall, Incorporated.

At step 70, a threshold calculation sets first threshold value T1 as a function of the estimated first pulse amplitude. In general, first threshold value T1 is set to a predetermined percentage of the estimated first pulse amplitude. The correction factor, first dielectric parameter, and second dielectric parameter, can be set by an operator who could be, for example, communicating with microprocessor system over process control loop 36 from control room 24. The operator can set the parameters using a computer by either inputting the values with a keyboard and/or

selecting the values from a table, which can be stored for use by, for example, threshold calculation module 56.

In one embodiment, a threshold calculation  
5 is made to establish fiducial threshold TF. Here, an estimated fiducial pulse amplitude is calculated at step 72 as a function of the reference amplitude, the correction factor, and the first dielectric parameter, which were set at steps 60 and 62,  
10 respectively. Threshold calculations then can set fiducial threshold value TF as a function of the estimated fiducial pulse amplitude, at step 74. Generally, fiducial threshold value TF is set to a predetermined percentage of the estimated fiducial  
15 pulse amplitude. Alternatively, fiducial threshold value TF can be set empirically, by an operator.

In another embodiment, the threshold calculations include a calculation of second threshold value T2, which can be used to detect  
20 second reflected wave pulse 46 corresponding to a portion of the transmitted microwave pulse reflected off second material interface 20. Here, a third dielectric parameter is set at step 76. The third dielectric parameter has a value that corresponds to  
25 the dielectric of third material 16 (FIG. 2). At step 78, an estimated second pulse amplitude is calculated as a function of the reference amplitude, the correction factor, and the first, second, and third dielectric parameters. Finally, at step 80, second

5 In one embodiment of the invention, the correction factor has a temperature dependence. This temperature dependence can be taken into account by either using an equation that calculates the correction factor as a function of temperature or by  
10 using a look up table for the particular antenna 22. In one embodiment, microprocessor system 30 can receive a temperature signal (not shown) that relates to the temperature of the materials in tank 12 and radar antenna 22. Here, microprocessor 50 can  
15 calculate the correction factor as a function of the temperature signal or select the appropriate correction factor that corresponds to the measured temperature.

In yet another embodiment, the correction factor is also a function of a range factor that generally corresponds to the type of scan to be performed by radar level transmitter 10. The range factor generally takes into account the attenuation of the reflected wave pulses that occurs when the reflected wave pulses travel through a medium. The greater the distance radar level transmitter 10 is to scan, the greater the attenuation of the reflected wave pulses. If this attenuation is not taken into account, detection errors can result. For example, if

the material interfaces are within a close range, the amplitude of the reflected wave pulses may be greater than expected resulting in the improper detection of some of the reflected wave pulses because the  
5 threshold values are set too low. Also, if the material interfaces are within a long range, the amplitude of the reflected wave pulses may be less than expected resulting in the failure to detect the reflected wave pulses because the threshold values  
10 are set too high. The range factor generally operates to adjust the threshold values such that reflected wave pulses that are reflected off material interfaces that are within a short or a long range will be properly detected.

15 In one embodiment, the range factor is set in accordance with either a long-range scan or a short-range scan. The distances corresponding to whether the range factor is set to the long-range or short-range scan depends, in part, on the type of  
20 radar antenna 22 being used. For example, if radar antenna 22 is in the form of a wave guide 22A, the range factor will be set to long-range if scans are to be made beyond a predetermined distance and set to short-range for scans shorter than the predetermined  
25 distance. The predetermined distance could be, for example, fifteen feet. The range factor can be used to either increase or decrease the threshold value depending on the type of scan to be performed.

In yet another embodiment, fiducial threshold value TF, first threshold value T1, and second threshold value T2 can be offset by an offset value that is set by an operator. The offset value  
5 can be used to either increase or decrease the desired threshold values by a fixed amount. These adjustments are generally made after an examination of the performance of the radar level transmitter 10.

Radar level transmitter 10 can also include  
10 a dielectric constant calculator (not shown) that is configured to calculate a dielectric constant of second material 14 as a function of the amplitude of the first reflected wave pulse 44 and the reference amplitude. The use of a dielectric calculator in a  
15 radar level transmitter 10 is disclosed in U.S. Patent Application Serial No. 09/234,999 filed January 11, 1999 and entitled, MULTIPLE PROCESS PRODUCT INTERFACED DETECTION FOR A LOW POWER RADAR LEVEL TRANSMITTER, which is herein incorporated by  
20 reference. In this embodiment, threshold calculation module 56 can recalculate the estimated first pulse amplitude and threshold value T1 with the first dielectric parameter set to the calculated dielectric constant. As a result, threshold calculation module  
25 56 can initially calculate first threshold value T1 in accordance with the first dielectric constant which is set by an operator and later adjust first threshold value T1 in response using the value obtained from a dielectric constant calculator.

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WHAT IS CLAIMED IS:

1. A method for automatically setting threshold values for use by a microwave level transmitter to detect reflected pulses corresponding to portions of a transmitted microwave pulse, the method comprising:

calculating an estimated first reflected pulse amplitude as a function of:

a correction factor;

a first dielectric parameter having a value corresponding to a dielectric of a first material adjacent to an antenna;

a reference amplitude of a transmitted microwave pulse; and

a second dielectric parameter having a value corresponding to a dielectric of a second material located below the first material; and

setting a first threshold value as a function of the estimated first reflected pulse amplitude.

2. The method of claim 1, wherein:

a first material interface is formed between the first and second materials; and

a first reflected pulse, corresponding to a portion of the transmitted microwave pulse reflected at the first material interface, is detectable using the first threshold

value.

3. The method of claim 1, wherein the first threshold value is further a function of at least one of an attenuation factor, a range factor, and an offset value.

4. The method of claim 1, further comprising:  
calculating an estimated second reflected pulse amplitude as a function of the reference amplitude, the correction factor, the first dielectric parameter, the second dielectric parameter, and a third dielectric parameter having a value corresponding to a dielectric of a third material located below the second material; and  
setting a second threshold value as a function of the estimated second reflected pulse amplitude.

5. The method of claim 4, wherein:  
a second material interface is located between the second and third materials; and  
a second reflected wave pulse, corresponding to a portion of the transmitted microwave pulse reflected at the second material interface, is detectable using the second threshold value.

6. The method of claim 4, wherein the second threshold value is further a function of at least one of an attenuation factor, a range factor, and an offset value.
7. The method of claim 1, further comprising:
  - calculating an estimated fiducial pulse amplitude as a function of the reference amplitude, the correction factor, and the first dielectric parameter; and
  - setting a fiducial threshold value as a function of the estimated fiducial pulse amplitude.
8. The method of claim 7, wherein:
  - a fiducial interface is formed between the antenna and the first material; and
  - a fiducial pulse, corresponding to a portion of the transmitted microwave pulse reflected at the fiducial interface is detectable using the fiducial threshold value.
9. The method of claim 7, wherein the fiducial threshold value is further a function of at least one of an attenuation factor, a range factor, and an offset value.
10. A method for automatically setting threshold values for use by a microwave level transmitter to detect reflected pulses corresponding to portions of a transmitted microwave pulse, the method comprising:

11. The method of claim 10, wherein:
  - a first material interface is formed between the first and second materials; and
  - a first reflected pulse, corresponding to a portion of the transmitted microwave pulse reflected at the first material interface, is detectable using the first threshold value.
12. The method of claim 10, further comprising:
  - setting a third dielectric parameter to a value corresponding to a dielectric of a third material located below the second material

a first material interface is formed between the first and second materials; and

a first reflected pulse, corresponding to a portion of the transmitted microwave pulse reflected at the first material interface, is detectable using the first threshold value.

setting a third dielectric parameter to a value  
corresponding to a dielectric of a third  
material located below the second material

calculating a second pulse amplitude as a function of the reference amplitude, the correction factor, and the first, second and third dielectric parameters; and  
setting a second threshold value as a function of the second pulse amplitude, whereby a second reflected wave pulse, corresponding to a portion of the microwave pulse reflected at a second material interface, can be detected using the second threshold value.

13. The method of claim 10, further comprising:  
calculating a fiducial pulse amplitude as a function of the reference amplitude, the correction factor, and the first dielectric parameter; and  
setting a fiducial threshold value as a function of the fiducial pulse amplitude, whereby a fiducial pulse, corresponding to a portion of the microwave pulse reflected off a fiducial interface, is detectable using the fiducial threshold value.

14. The method of claim 10, wherein the first threshold value is further a function of at least one of an attenuation factor, a range factor, an offset value, and temperature.

16. The method of claim 10, further comprising:  
receiving a calculated dielectric constant relating to the dielectric constant of the second material from a dielectric constant calculator;  
re-calculating the estimated first pulse amplitude using the calculated dielectric constant; and  
setting the first threshold value as a function of the re-calculated estimated first pulse amplitude.

an antenna;

a transceiver coupled to the antenna and configured to: transmit a microwave pulse having an amplitude using the antenna and produce a signal representing reflected wave pulses;

a microprocessor system coupled to the transceiver and adapted to control the transceiver and process the signal;

a level calculation module executable by the microprocessor system and adapted to establish a level of a first material interface using the signal and the first threshold value.

the threshold calculating module is further adapted to calculate a second threshold value as a function of the amplitude and the properties of the materials; and

19. The radar level transmitter of claim 17, including an input/output port adapted to transmit a level output that is indicative of the first material interface.

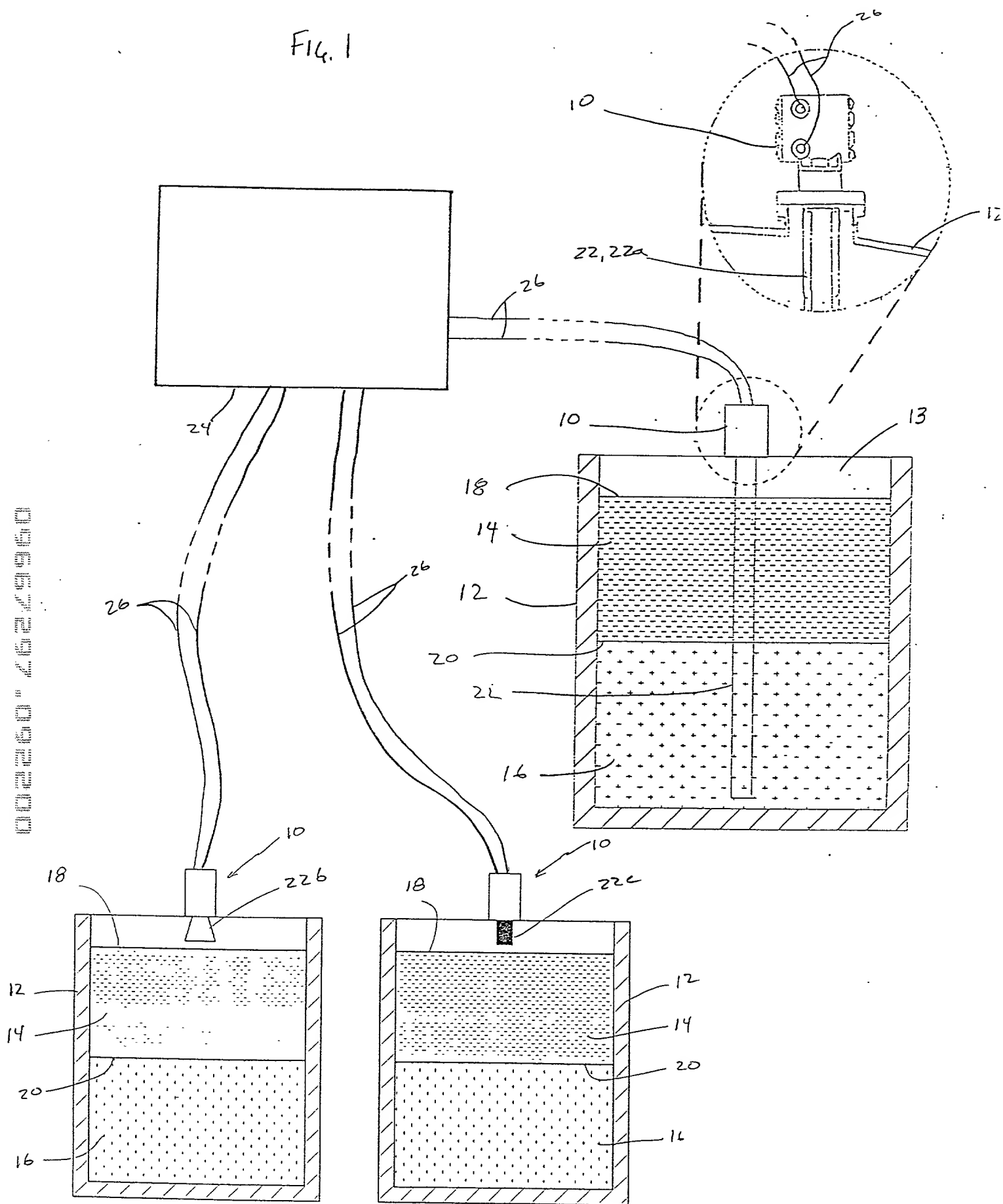
20. The radar level transmitter of claim 17,  
including a dielectric constant calculator adapted to

Variable	Mean	SD	Min	Max
Age	34.5	10.2	21	55
Gender	1.2	0.4	1	2
Marital status	1.5	0.5	1	3
Education	12.5	1.5	9	16
Occupation	1.8	0.8	1	3
Income	1.5	0.5	1	3
Health status	1.2	0.4	1	2
Stress level	2.5	1.0	1	4
Life satisfaction	3.5	1.5	1	5
Resilience	2.8	1.2	1	4
Optimism	3.2	1.0	1	4
Self-efficacy	3.0	1.0	1	4
Emotional stability	2.5	1.0	1	4
Prosocial behavior	2.8	1.0	1	4
Empathy	3.0	1.0	1	4
Altruism	2.5	1.0	1	4
Compassion	2.8	1.0	1	4
Kindness	2.5	1.0	1	4
Generosity	2.8	1.0	1	4
Helpfulness	2.5	1.0	1	4
Cooperativeness	2.8	1.0	1	4
Teamwork	2.5	1.0	1	4
Leadership	2.8	1.0	1	4
Communication	2.5	1.0	1	4
Conflict resolution	2.8	1.0	1	4
Problem solving	2.5	1.0	1	4
Decision making	2.8	1.0	1	4
Goal setting	2.5	1.0	1	4
Time management	2.8	1.0	1	4
Organization	2.5	1.0	1	4
Productivity	2.8	1.0	1	4
Efficiency	2.5	1.0	1	4
Quality of work	2.8	1.0	1	4
Job satisfaction	2.5	1.0	1	4
Work-life balance	2.8	1.0	1	4
Stress management	2.5	1.0	1	4
Emotional regulation	2.8	1.0	1	4
Self-awareness	2.5	1.0	1	4
Empathy	2.8	1.0	1	4
Compassion	2.5	1.0	1	4
Kindness	2.8	1.0	1	4
Generosity	2.5	1.0	1	4
Helpfulness	2.8	1.0	1	4
Cooperativeness	2.5	1.0	1	4
Teamwork	2.8	1.0	1	4
Leadership	2.5	1.0	1	4
Communication	2.8	1.0	1	4
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Quality of work	2.5	1.0	1	4
Job satisfaction	2.8	1.0	1	4
Work-life balance	2.5	1.0	1	4
Stress management	2.8	1.0	1	4
Emotional regulation	2.5	1.0	1	4
Self-awareness	2.8	1.0	1	4

## ABSTRACT

Disclosed is a method and apparatus for  
5 setting threshold values for use by a radar level  
transmitter to detect reflected wave pulses  
corresponding to portions of a transmitted microwave  
pulse which reflect from interfaces contained in a  
container. The present invention estimates these  
10 threshold values based upon various parameters. Some  
of these parameters can relate to properties of the  
materials forming the interfaces while others relate  
to properties of the antenna and user-defined  
parameters.

FIG. 1



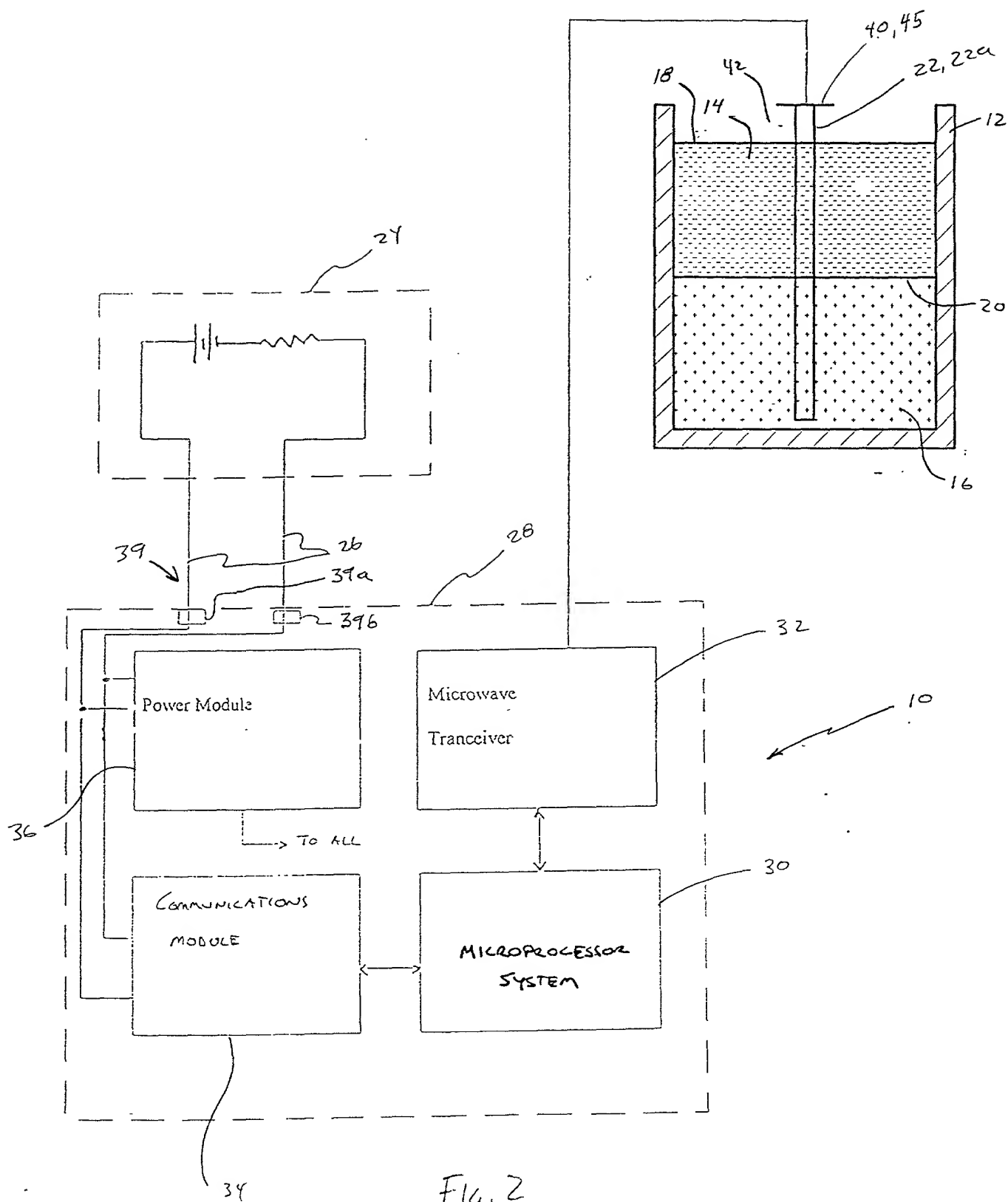
[illegible]

Fig. 2

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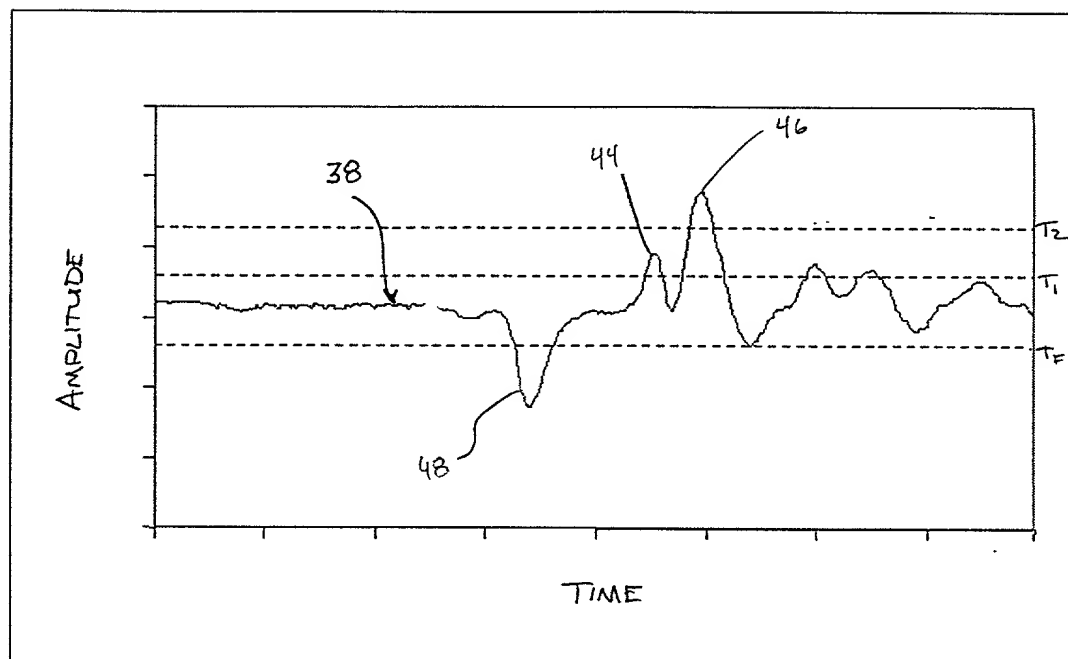


Fig. 3

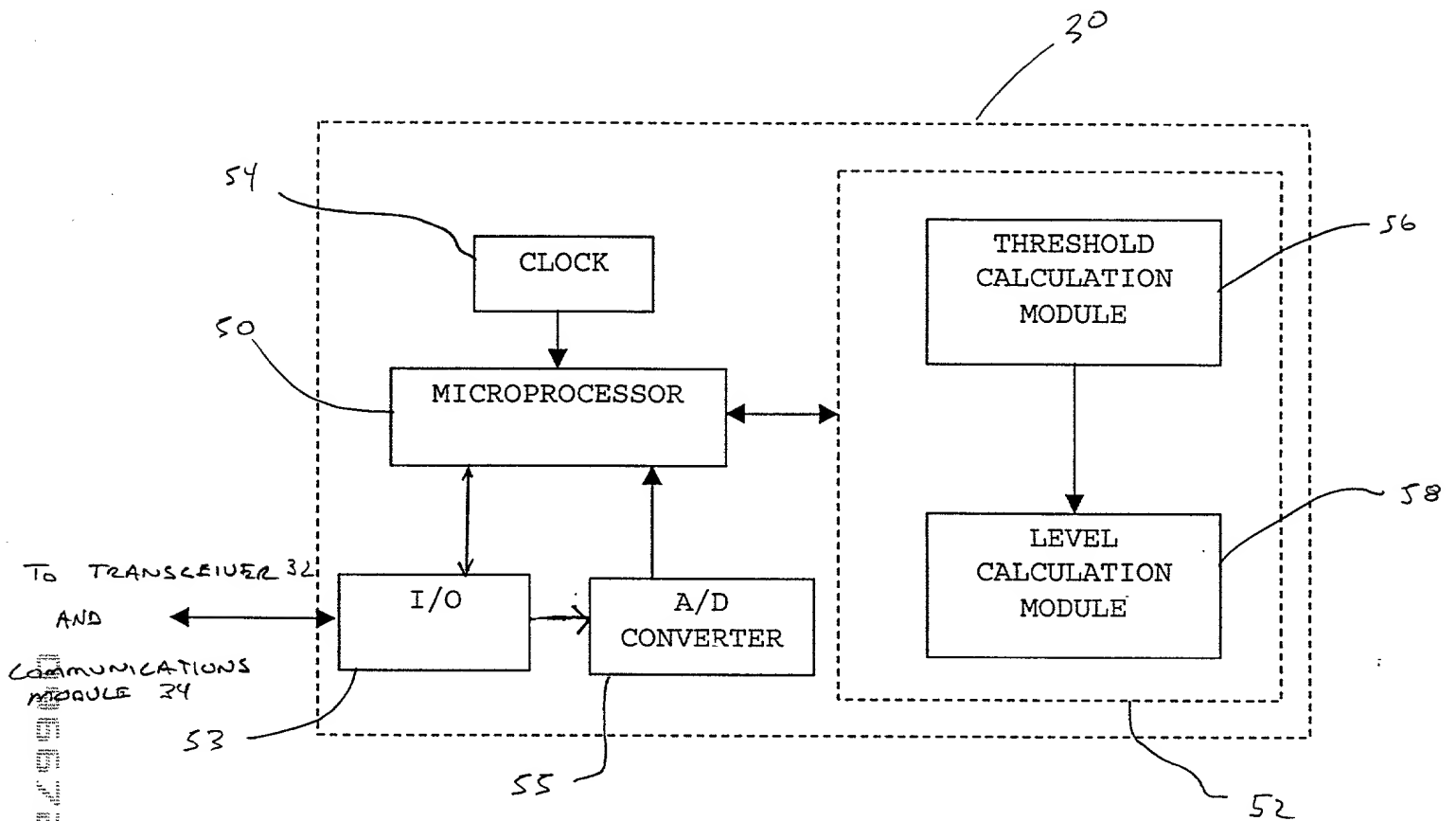


FIG. 4

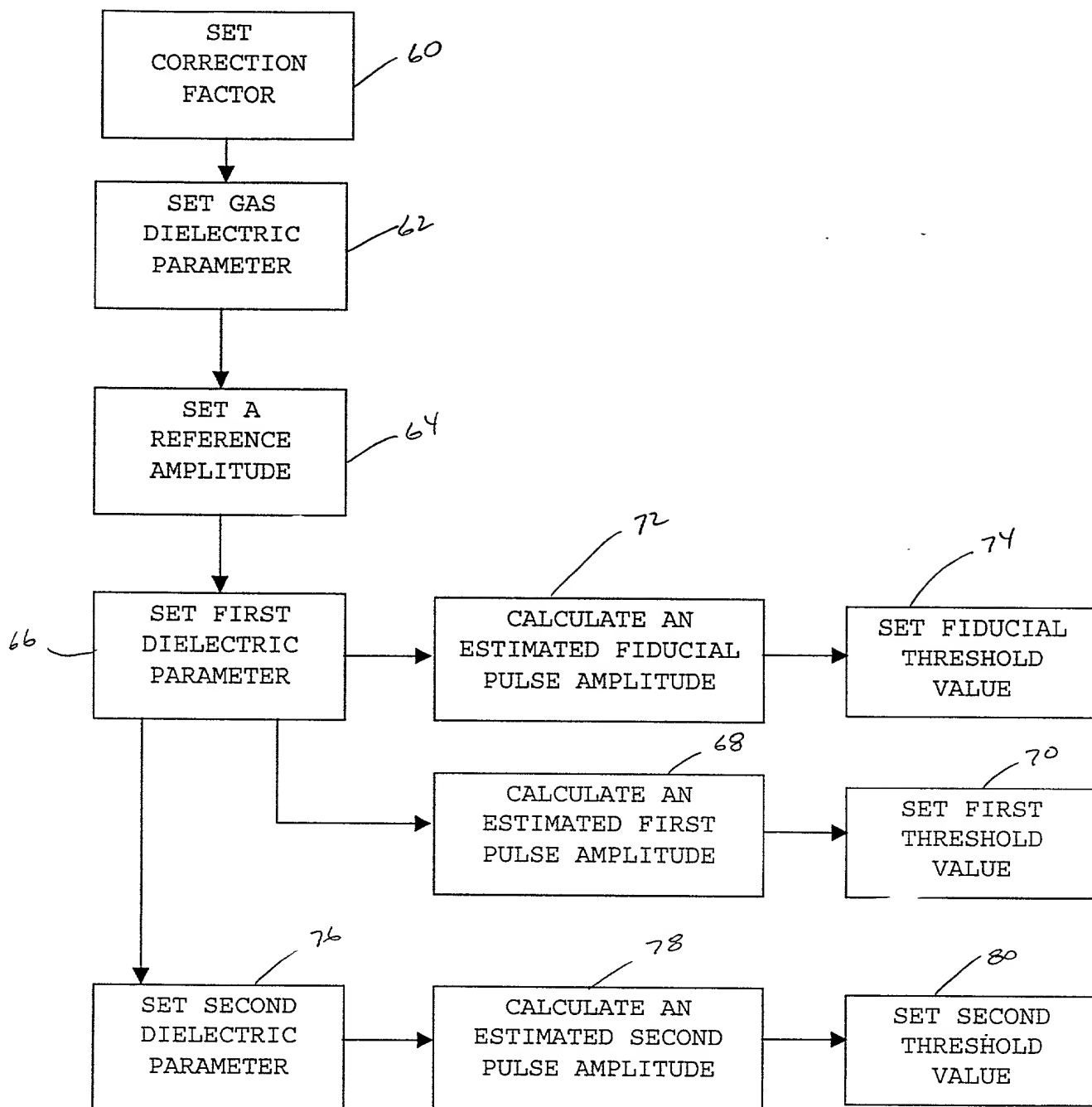


Fig. 5

**DECLARATION  
IN ORIGINAL APPLICATION**

Attorney Docket No.

R11.12-0701

**SPECIFICATION AND INVENTORSHIP IDENTIFICATION**

As a below named inventor, I declare that:

My residence, post office address and citizenship are as stated below next to my name.

I believe I am the original, first and joint inventor of the subject matter which is claimed, and for which a patent is sought, on the invention entitled IMPROVED THRESHOLD SETTING FOR A RADAR LEVEL TRANSMITTER the specification of which,

(check one) X is attached hereto.

\_\_\_\_\_ was filed on \_\_\_\_\_ as Appln. No. \_\_\_\_\_.

\_\_\_\_\_ and was amended on \_\_\_\_\_.

\_\_\_\_\_ was described and claimed in PCT International Application No. \_\_\_\_\_ filed on \_\_\_\_\_ and as amended under PCT Article 19 on \_\_\_\_\_.

**ACKNOWLEDGEMENT OF REVIEW OF PAPERS AND DUTY OF CANDOR**

I have reviewed and understand the contents of the above identified specification, including the claims, as amended by any amendment referred to above. I acknowledge the duty to disclose information which is known to me to be material to the patentability of this application in accordance with 37 C.F.R. § 1.56.

**PRIORITY CLAIM (35 U.S.C. § 119)**

Prior Foreign Application(s)

I claim foreign priority benefits under 35 U.S.C. § 119(a-d) of any foreign application(s) for patent or inventor's certificate listed below, each of which is incorporated by reference in its entirety, and have also identified below any foreign application for patent or inventor's certificate having a filing date before that of the application on which priority is claimed:

Number	Country	Day/Month/Year Filed	Priority Claimed
_____	_____	_____	Yes____ No____
_____	_____	_____	Yes____ No____

Prior Provisional Application(s)

I hereby claim the benefit under 35 U.S.C. §119(e) of any United States Provisional Application(s) listed below, each of which is incorporated by reference in its entirety:

Number	Day/Month/Year Filed
_____	_____

PRIORITY CLAIM (35 U.S.C. § 120)

I claim the benefit under 35 U.S.C. § 120 of any United States application(s) listed below, each of which is incorporated by reference in its entirety. Insofar as the subject matter of each of the claims of this application is not disclosed in the prior United States application in the manner provided by the first paragraph of 35 U.S.C. § 112, I acknowledge the duty to disclose to the Patent Office all information known to me to be material to patentability as defined in 37 C.F.R. § 1.56 which became available between the filing date of the prior application and the national or PCT international filing date of this application:

Appln. No.	U.S. Appln. No. (if any under PCT)	Filing Date	Status
_____	_____	_____	_____
_____	_____	_____	_____

DECLARATION

I declare that all statements made herein that are of my own knowledge are true and that all statements that are made on information and belief are believed to be true; and further that these statements were made with the knowledge that willful false statements and the like so made are punishable by fine or imprisonment, or both, under 18 U.S.C. § 1001 of Title 18 of the United States Code and that such willful false statements may jeopardize the validity of the application or any patent issued thereon.

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